

Supporting Information

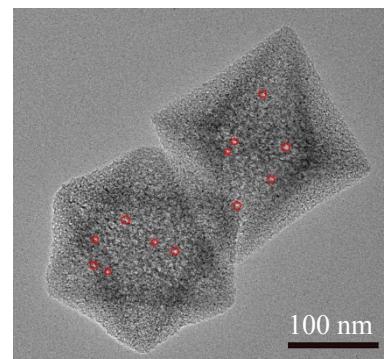


Fig.S1 HAADF-STEM image of the N-PC sample.

Table S1. The atomic fractions of N-PC and PC, obtained by XPS.

Sample	C [at%]	N [at%]	O [at%]
N-PC	84.94	10.90	4.16
PC	87.37	6.69	5.94

Table S2. Fractions of the different N species present in PC and N-PC.

Sample	Oxidized-N [%]	Graphitic-N [%]	Pyrrolic-N [%]	Pyridinic-N [%]
N-PC	10.32	17.44	51.72	20.52
PC	21.37	12.41	50.07	16.15

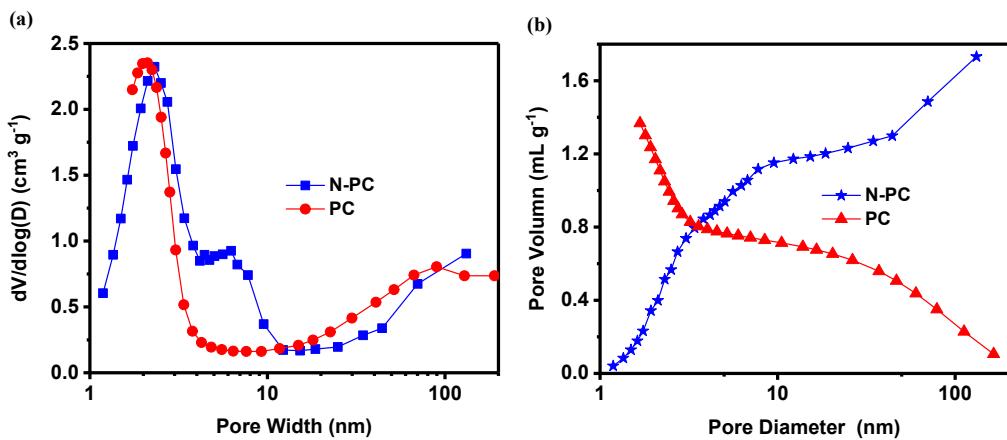


Fig.S2 (a) Pore-size distributions of PC and N-PC; (b) pore volumes of PC and N-PC.

Table S3. Surface areas of UIO-66-NH₂ and N@UIO-66-NH₂.

Sample	$S_{\text{BET}}/\text{m}^2 \text{ g}^{-1}$
UIO-66-NH ₂	1109
N@ UIO-66-NH ₂	627

Table S4. Surface areas, mesopore volumes, and meso-porosity of prepared samples.

Sample	$S_{\text{BET}}/\text{m}^2 \text{ g}^{-1}$	$V_{\text{mes}}/\text{cm}^3 \text{ g}^{-1}$	Mesoporosity/%
PC	1804	0.799	58
N-PC	1697	1.143	66

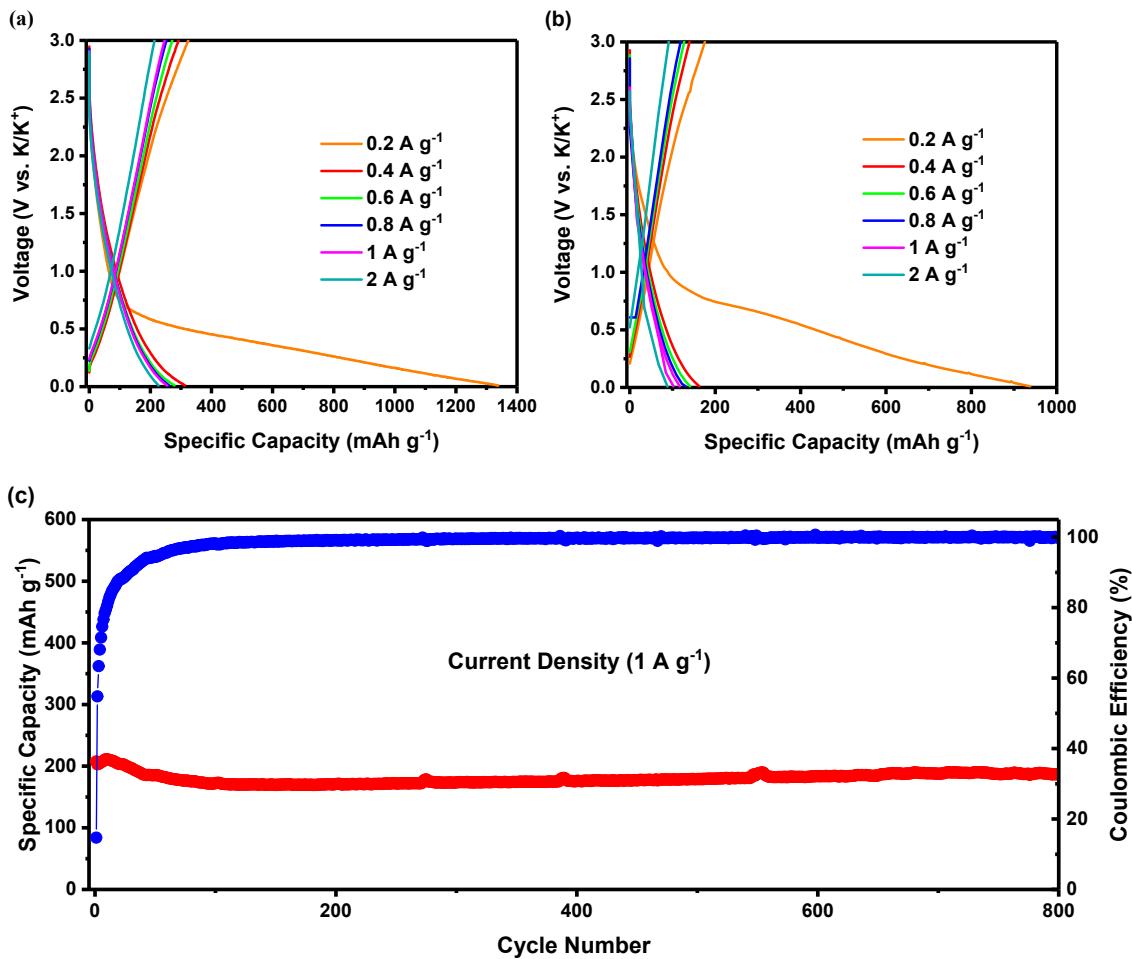


Fig.S3 The galvanostatic charge/discharge profiles of (a) N-PC and (b) PC at different rates; (c) cycling performance of N-PC at a current density of 1 A g⁻¹.

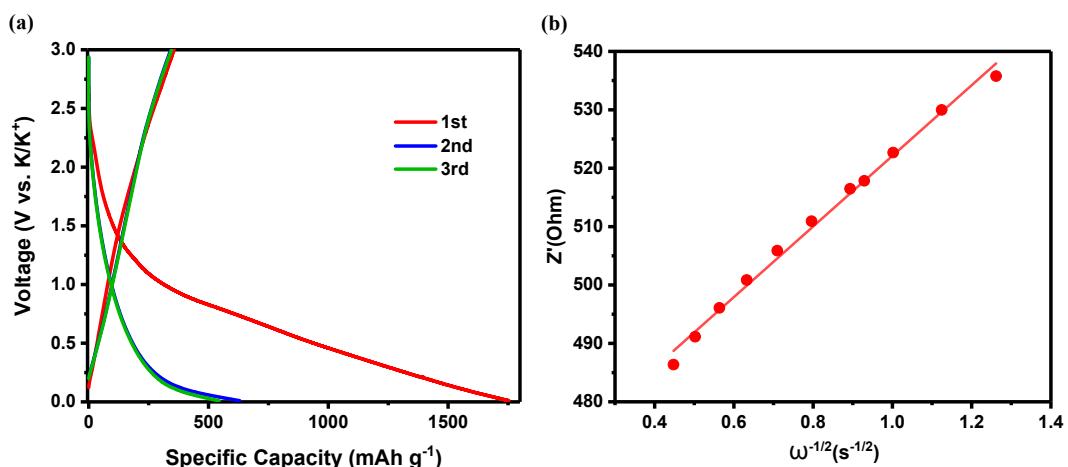


Fig.S4 (a) The first three charge-discharge profiles of N-PC at 0.1 A g⁻¹; (b) the linear relation

between $\omega^{-1/2}$ and Z' at low frequencies.

Table S5 The simulated results from EIS data of PC and N-PC.

Sample	$R_s(\Omega)$	$R_{ct}(\Omega)$	$D_{K^+} (\text{cm}^{-2} \text{s}^{-1})$
N-PC	4.19	232.19	3.47×10^{-11}
PC	4.21	500.85	2.48×10^{-11}